		Application/Control No.	Applicant(s)/Patent Under Reexamination
Notice of References Cited		09/847,051	MARTINEK ET AL.
		Examiner	Art Unit	Page 2 of 3
		Steven Ashburn	3714	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Get Control, Inc., PC-104 DIG-IO-48 Plus, <http://www.getcontrol.com> downloaded from the internet on March 20, 2003, p. 1.
	V	D. Powell et al., GUARDS: a generic upgradeable architecture for real-time dependable systems, Parallel and Distributed Systems, IEEE Transactions on , Volume: 10, Issue: 6 , Jun 1999, pp. 580 –599
	W	Robert, A. Burkle, PC/104 Embedded Modules: The New Systems Components, <http://www.winsystems.com/papers/sys_components.pdf> downloaded from the Internet on Mar. 20, 2003, pp. 1-3.
	X	WinSystems, <www.winsystems.com> downloaded from the Internet on Apr. 2, 2003, pp. 1-25.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Jim Blazer, PC/104 Intelligent Data Acquisition, PC/104 Embedded Solutions (Spring 1998), pp. 1-2.
	V	Robert A. Burckle, STD Bus: Performance without Complexity, <http://www.winsystems.com/papers/stdperformance.pdf> (Aug. 1, 2001), pp. 1-3.
	W	Craig Matasumoto, Intel starts preaching about security, EE Times <http://eetimes.com/story/OEG19990121S0014> (Jan. 21, 1999), pp. 1-4.
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

	Application/Control No.	Applicant(s)/Patent Under Reexamination
Notice of References Cited	09/847,051	MARTINEK ET AL.
	Examiner	Art Unit	
	Steven Ashburn	3714	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,135,884	10-2000	Hedrick et al.	463/20
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	RTD.USA, <www.rtdusa.com> (1998), downloaded from the Internet on Mar. 20, 2003, pp. 1-49.
/	V	Mardsen et al., Development of a PC-Windows Based Universal Control System, 5th Intl. Conf. on FACTORY 2000, 2-4 April, 1997, Conf. Pub. No. 435, pp. 284-287.
/	W	Paul Virgo, Embedded PC's for the Industrial Marketplace: An Analysis of the STD Bus, WESCON/'93. Conference Record, Sep 28-30, 1993, pp. 621 –623
/	X	Jahn Luke et al., A commercial off-the-shelf based replacement strategy for aging avionics computers, Aerospace and Electronics Conference, 1998. NAECON 1998, Proceedings of the IEEE 1998 National , 13-17 Jul 1998, pp. 177 –181

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.